

Search Notes

Application/Control No.

10/694,067

Examiner

Trinh T. Nguyen

Applicant(s)/Patent under
Reexamination

BRUTSCHE ET AL.

Art Unit

3644

SEARCHED

Class	Subclass	Date	Examiner
47	65.5,71, 66.6,79, 65.6	9/28/2005	TTN
D11	143,152,	↓	↓
	155,164	↓	↓

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor name search was performed.	9/28/2005	TTN